





SECONDARY SIDE SYNCHRONOUS RECTIFICATION SWITCHER

Description

APR3415 is a secondary side Combo IC, which combines an N-Channel MOSFET and a driver circuit designed for synchronous rectification (SR) in DCM operation. It also integrates output voltage detect function for primary side control system.

The N-Channel MOSFET has been optimized for low gate charge, low $R_{\rm DS(ON)}$, fast switching speed and body diode reverse recovery performance.

The synchronous rectification can effectively reduce the secondary side rectifier power dissipation and provide high performance solution. By sensing MOSFET drain-to-source voltage, APR3415 can output ideal drive signal with less external components. It can provide high performance solution for 5V output voltage application.

Same as AP4341, APR3415 detects the output voltage and provides a periodical signal when the output voltage is lower than a certain threshold. By fast response to secondary side voltage, APR3415 can effectively improve the transient performance of primary side control system.

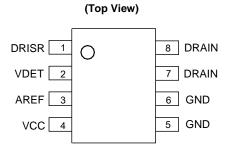
The APR3415 is available in SO-8 package.

Features

Notes:

- Synchronous Rectification for DCM Operation Flyback
- Eliminate Resonant Ring Interference
- Fast Detector of Supply Voltages
- Fewest External Components
- Totally Lead-free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Pin Assignments



SO-8

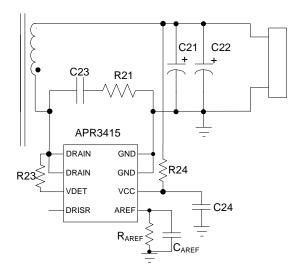
Applications

- Adapters/Chargers for Cell/Cordless Phones, ADSL Modems, MP3 and Other Portable Apparatus
- Standby and Auxiliary Power Supplies

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

Typical Applications Circuit



APR3415
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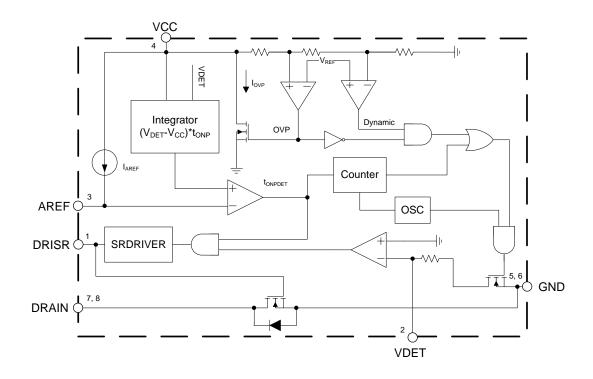
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Pin Descriptions

| Pin Number | Pin Name | Function |
|------------|----------|---|
| 1 | DRISR | Synchronous rectification MOSFET drive |
| 2 | VDET | Synchronous rectification sense input and dynamic function output, connected to DRAIN through a resistor |
| 3 | AREF | Program a voltage reference with a resistor from AREF to GND, to enable synchronous rectification MOSFET drive signal |
| 4 | VCC | Power supply, connected with system output |
| 5, 6 | GND | Source pin of internal MOSFET, connected to Ground |
| 7, 8 | DRAIN | Drain pin of internal MOSFET |

Functional Block Diagram





Absolute Maximum Ratings (Note 4)

| Symbol | Parameter | Value | Unit |
|--|---|-------------|------|
| V _{cc} | Supply Voltage | -0.3 to 7.5 | V |
| V _{DET} , V _{DRAIN} | Voltage at VDET, DRAIN Pin | -2 to 50 | V |
| V _{AREF} , V _{DRISR} | Voltage at AREF, DRISR Pin | -0.3 to 6 | V |
| I _D | Continuous Drain Current | 15 | А |
| I _{DM} | Pulsed Drain Current | 60 | А |
| P _D | Power Dissipation at T _A =+25°C | 0.7 | W |
| θ_{JA} | Thermal Resistance (Junction to Ambient) (Note 5) | 170 | °C/W |
| θ _{JC} | Thermal Resistance (Junction to Case) (Note 5) | 24 | °C/W |
| TJ | Operating Junction Temperature | +150 | °C |
| T _{STG} | Storage Temperature | -65 to +150 | °C |
| T _{LEAD} | Lead Temperature (Soldering, 10 sec) | +300 | °C |

Notes:

Recommended Operating Conditions

| Symbol | Parameter | Min | Max | Unit |
|-----------------|---------------------|-----|-----|------|
| V _{cc} | Supply Voltage | 3.3 | 6 | V |
| T _A | Ambient Temperature | -40 | +85 | °C |

^{4.} Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "Recommended Operating Conditions" is not implied. Exposure to "Absolute Maximum Ratings" for extended periods may affect device reliability.

^{5.} FR-4 substrate PC board, 2oz copper, with 1 inch² pad layout.



Electrical Characteristics (@ $T_A = +25^{\circ}C$, $V_{CC} = 5V$, unless otherwise specified.)

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--|---------------------------------------|--|-------|-------|-------|-------|
| Supply Voltage (| VCC Pin) | | | | | • |
| I _{STARTUP} | Startup Current | V _{CC} =V _{STARTUP} -0.1V | _ | 100 | 150 | μΑ |
| I _{OP} | Operating Current | VDET pin floating V _{CC} =V _{TRIGGER} +20mV | 40 | 100 | 150 | μΑ |
| V _{STARTUP} | Startup Voltage | - | 2.6 | 3.1 | 3.4 | V |
| _ | UVLO | - | 2.3 | 2.8 | 3.1 | V |
| Dynamic Output S | Section/Oscillator Section | | • | | | |
| $V_{TRIGGER}$ | Internal Trigger Voltage | - | 5.25 | 5.3 | 5.35 | V |
| _ | Duty Cycle | - | 4 | 8 | 12 | % |
| tosc | Oscillation Period | V _{CC} =5V | 18 | 30 | 37.5 | μs |
| I _{TRIGGER} | Internal Trigger Current | $V_{\text{CC}} = V_{\text{TRIGGER}}$, VCC/VDET pin is separately connected to a 20Ω resistor | 30 | _ | 42 | mA |
| t _{DIS} | Minimum Period | - | 18 | 30 | 37.5 | ms |
| V_{DIS} | Discharge Voltage | - | 5.28 | 5.44 | 5.52 | V |
| I _{DIS} | Discharge Current | V _{CC} =V _{DIS} +0.1V | 1.5 | 3 | 4.5 | mA |
| V _{DIS} -V _{TRIGGER} | Trigger Discharger Gap | - | 30 | 110 | - | mV |
| V _{OVP} | Overshoot Voltage for Discharge | _ | 5.8 | 5.9 | 6.0 | V |
| I _{OVP} | Overshoot Current for Discharge | V _{CC} =V _{OVP} +0.1V, VCC pin is connected to a 20Ω resistor | 40 | - | 100 | mA |
| Synchronous Vol | tage Detect | | | | | |
| V_{THON} | Gate Turn On Threshold | - | 0 | _ | 1 | V |
| V_{THOFF} | Gate Turn Off Threshold | - | -20 | -12.5 | -5 | mV |
| t _{DON} | Turn On Delay Time | From V _{THON} to V _{DRISR} =1V | - | 70 | 130 | ns |
| t _{DOFF} | Turn Off Propagation Delay Time | From V _{THOFF} to V _{DRISR} =3V | - | 100 | 150 | ns |
| t _{RG} | Gate Turn On Rising Time | From 1V to 3V, C _L =4.7nF | - | 50 | 100 | ns |
| t _{FG} | Gate Turn Off Falling Time | From 3V to 1V, C _L =4.7nF | - | 50 | 100 | ns |
| t _{LEB_S} | Minimum On Time | $(V_{DET}-V_{CC})*t_{ONP}=25V\mu s$ | 0.9 | 1.8 | 2.7 | |
| t _{LEB_L} | Minimum On Time | (V _{DET} -V _{CC})*t _{ONP} = 50Vμs | _ | _ | 6.5 | μs |
| V _{DRISR_HIGH} | Drive Output Voltage | V _{CC} =5V | 3.7 | - | _ | V |
| V _{S_MIN} | SR Minimum Operating Voltage (Note 6) | - | | - | 4.5 | V |
| t _{OVP_LAST} | Added OVP Discharge Time | - | _ | 2.0 | _ | ms |
| Kqs | (Note 7) | (V _{DET} -V _{CC})*t _{ONP} = 25Vµs | 0.325 | - | 0.515 | mA*µs |

Notes: 6. This item specifies the minimum SR operating voltage of V_{IN_DC} , $V_{IN_DC} \ge N_{PS}^* V_{S_MIN.}$

7. This item is used to specify the value of $\ensuremath{\mathsf{R}}_{\ensuremath{\mathsf{AREF}}}.$



Electrical Characteristics (@TA =+25°C, unless otherwise specified. Cont.)

MOSFET Static Characteristics

| Parameters | Symbol | Conditions | Min | Тур | Max | Unit |
|--|----------------------|---|-----|-----|-----|------|
| Drain to Source Breakdown Voltage | V _{DSS(BR)} | V _{GS} =0V, I _D =0.25mA | 50 | - | - | V |
| Gate Threshold Voltage | $V_{GS(TH)}$ | V _{DS} =V _{GS} , I _D =0.25mA | 0.5 | 0.9 | 2 | V |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} =50V, V _{GS} =0V | - | - | 1 | μΑ |
| Gate to Source Leakage Current | I _{GSS} | V _{GS} =10V, V _{DS} =0V | - | - | ±10 | μΑ |
| Drain to Source On-state Resistance | R _{DS(ON)} | V _{GS} =4.5V, I _D =15A | 12 | 17 | 30 | mΩ |

MOSFET Dynamic Characteristics

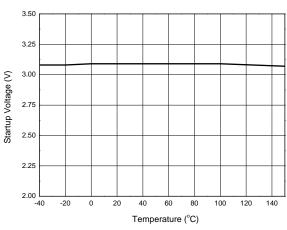
| Parameters | Symbol | mbol Conditions | | Тур | Max | Unit |
|--|------------------|---|---|------|-----|------|
| Input Capacitance | C _{iss} | | - | 1316 | _ | |
| Output Capacitance | Coss | V _{GS} =0V, V _{DS} =25V, f=1MHz | _ | 97 | _ | pF |
| Reverse Transfer Capacitance | C _{rss} | | _ | 85 | _ | |
| Gate to Source Charge | Qgs | | _ | 3.2 | _ | |
| Gate to Drain Charge (Miller Charger) | Q _{gd} | V_{GS} =0V to 10V, V_{DD} =25V, I_{D} =15A | _ | 5.7 | _ | nC |
| Total Gate Charge | Qg | | _ | 15.2 | - | |
| Gate Resistance | R _g | - | - | 0.85 | 1 | Ω |

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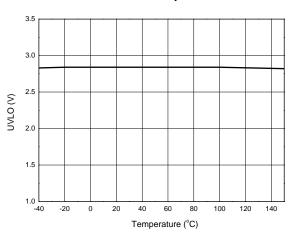


Performance Characteristics

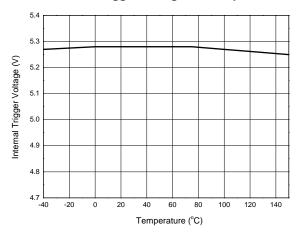
Startup Voltage vs. Temperature



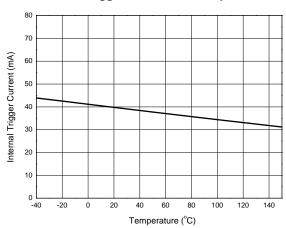
UVLO vs. Temperature



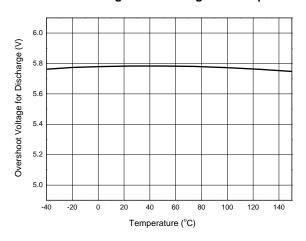
Internal Trigger Voltage vs. Temperature



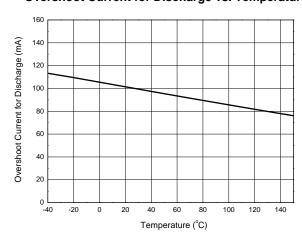
Internal Trigger Current vs. Temperature



Overshoot Voltage for Discharge vs. Temperature



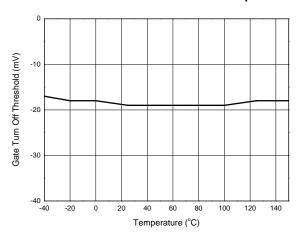
Overshoot Current for Discharge vs. Temperature



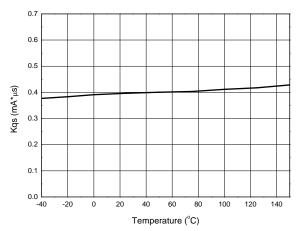


Performance Characteristics (Cont.)

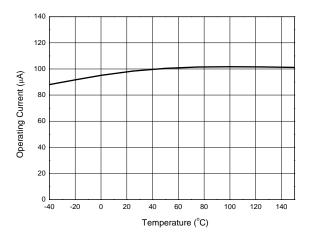
Gate Turn Off Threshold vs. Temperature



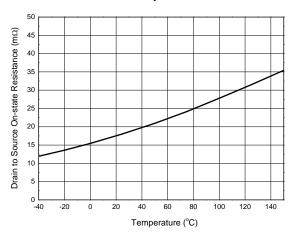
Kqs (See Note 7) vs. Temperature



Operating Current vs. Temperature



Drain to Source On-state Resistance vs. Temperature





Output Voltage Detect Function Description

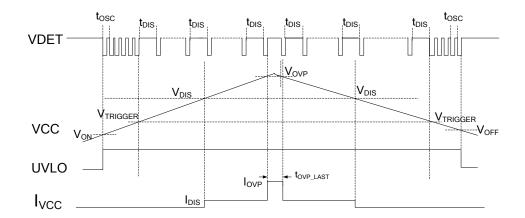


Figure 1. Typical Waveforms of APR3415

When V_{CC} is beyond power-on voltage (V_{ON}) , the APR3415 starts up. The VDET pin asserts a periodical pulse and the oscillation period is t_{OSC} . When V_{CC} is beyond the trigger voltage $(V_{TRIGGER})$, the periodical pulse at VDET pin is discontinued. When V_{CC} is beyond the discharge voltage (V_{DIS}) , the discharge circuit will be enabled, and a 3mA current (I_{DIS}) will flow into VCC pin. When V_{CC} is higher than the overshoot voltage (V_{OVP}) , the APR3415 will enable a discharge circuit, the discharge current (I_{OVP}) will last t_{OVP_LAST} time. After the t_{OVP_LAST} time, APR3415 will stop the discharge current and detect VCC voltage again. If V_{CC} is still higher than V_{OVP} , the t_{OVP_LAST} time discharge current will be enabled again. Once the OVP discharge current is asserted, the periodical pulse at VDET pin will be disabled.

When the V_{CC} falls below the power-off voltage (V_{OFF}), the APR3415 will shut down.

Operation Description

MOSFET Driver

The operation of the SR is described with timing diagram shown in Figure 2. APR3415 monitors the MOSFET drain-source voltage. When the drain voltage is lower than the turn-on threshold voltage V_{THON} , the IC outputs a positive drive voltage after a turn-on delay time (t_{DON}). The MOSFET will turn on and the current will transfer from the body diode into the MOSFET's channel.

In the process of drain current decreasing linearly toward zero, the drain-source voltage rises synchronically. When it rises over the turn off threshold voltage V_{THOFF} , APR3415 pulls the drive signal down after a turn off delay (t_{DOFF}).

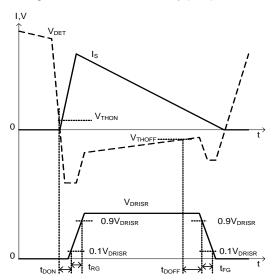


Figure 2. Typical Waveforms of APR3415

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Operation Description (Cont.)

Minimum On Time

When the controlled MOSFET gate is turned on, some ringing noise is generated. The minimum on-time timer blanks the V_{THOFF} comparator, keeping the controlled MOSFET on for at least the minimum on time. If V_{THOFF} falls below the threshold before minimum on time expires, the MOSFET will keep on until the end of the minimum on time.

The minimum on time is in direct proportion to the (V_{DET}-V_{CC})*t_{ONP}. When (V_{DET}-V_{CC})*t_{ONP}=5V*5µs, the minimum on time is about 1.8µs.

The Value and Meaning of AREF Resistor

As to DCM operation Flyback converter, after secondary rectifier stops conduction the primary MOSFET Drain-to-source ringing waveform is resulted from the resonant of primary inductance and equivalent switch device output capacitance. This ringing waveform probably leads to Synchronous Rectifier error conduction. To avoid this fault happening, APR3415 has a special function design by means of volt-second product detecting. From the sensed voltage of VDET pin to see, the volt-second product of voltage above VCC at primary switch on time is much higher than the volt-second product of each cycle ringing voltage above V_{CC} . Therefore, before every time Synchronous Rectifier turning on, APR3415 judges if the detected volt-second product of VDET voltage above V_{CC} is higher than a threshold and then turn on synchronous Rectifier. The purpose of AREF resistor is to determine the volt-second product threshold. APR3415 has a parameter, Kqs, which converts R_{AREF} value to volt-second product.

Area
$$2 = R_{ARFF} * Kqs$$

In general, Area1 and Area3, the value of which should be test on system, depend on system design and always are fixed after system design frozen. As to BCD PSR design, the Area1 value changes with primary peak current value and Area3 value generally keeps constant at all of conditions. So the AREF resistor design should consider the worst case, the minimum primary peak current condition. Since of system design parameter distribution, Area1 and Area3 have moderate tolerance. So Area2 should be designed between the middle of Area1 and Area3 to keep enough design margin.

Area3 < R AREF * Kqs < Area1

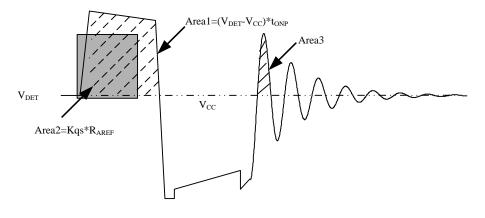


Figure 3. AREF Function

SR Minimum Operating Voltage

APR3415 sets a minimum SR operating voltage by comparing the difference between V_{DET} and output voltage (V_{CC}). The value of V_{DET} – V_{CC} must be higher than its internal reference, then APR3415 will begin to integrate the area of $(V_{DET}$ – $V_{CC})$ * t_{ONP} . If not, the area integrating will not begin and the SR driver will be disabled.

SR Turning off Timing Impact on PSR CV Sampling

As to synchronous rectification on Flyback power system, SR MOSFET need to turn off in advance of secondary side current decreasing to zero to avoid current flowing reversely. When SR turns off in advance, the secondary current will flow through the body diode. The SR turning off time is determined by the V_{THOFF} at a fixed system. When V_{THOFF} is more close to zero, the SR turning on time gets longer and body diode conduction time gets shorter. Since of the different voltage drop between SR MOSFET and body diode, the PSR feedback signal V_{FB} appears a voltage jump at the time of SR MOSFET turning off. If the PSR CV sampling time t_{SAMPLE} is close to even behind this voltage jump time, there will be system unstable operation issue or the lower output voltage issue.



Operation Description (Cont.)

To ensure stable operating of system, it must be met:

 $t_{BODYDIODE} < t_{ONS}^* (1 - t_{SAMPLE})$

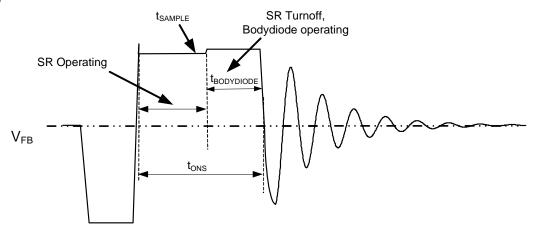


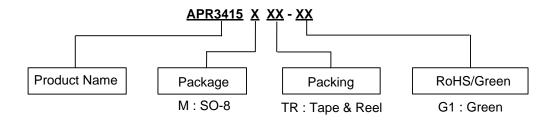
Figure 4. SR Turning off Timing Impact on PSR CV Sampling

Recommended Application Circuit Parameters

The two resistors R23 and R24 are used to pass ESD test. The value of R23 and R24 should be over 20Ω and below 47Ω respectively because of the undershoot performance. The package of R23 and R24 should be at least 0805 and there isn't any trace under these two resistors.

 C_{AREF} is suggested to parallel with AREF resistor to keep the volt-second product threshold stable. And the recommended value of C_{AREF} is 100nF. The recommended value of C24 is 100nF.

Ordering Information

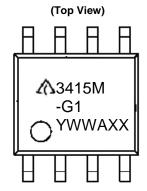


| Package | Temperature Range | Part Number | Marking ID | Packing |
|---------|-------------------|---------------|------------|------------------|
| SO-8 | -40 to +85°C | APR3415MTR-G1 | 3415M-G1 | 4000/Tape & Reel |

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Marking Information



First and Second Lines: Logo and Marking ID

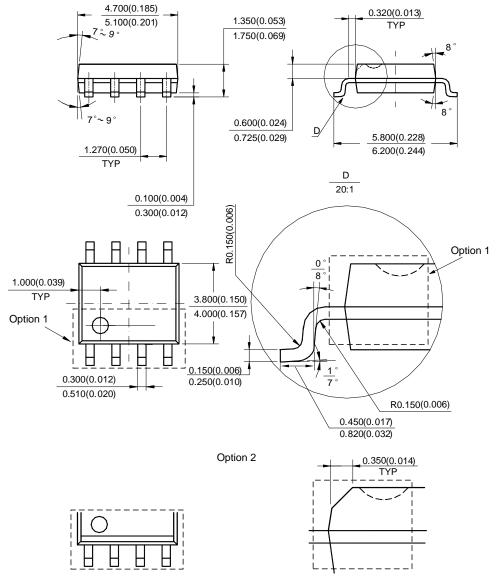
Third Line: Date Code

Y: Year

WW: Work Week of Molding
A: Assembly House Code
XX: 7th and 8th Digits of Batch No.

Package Outline Dimensions (All dimensions in mm(inch).)

(1) Package Type: SO-8

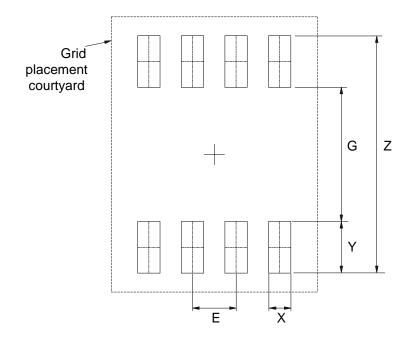


Note: Eject hole, oriented hole and mold mark is optional.



Suggested Pad Layout

(1) Package Type: SO-8



| Dimensions | Z | G | X | Y | E |
|------------|-------------|-------------|-------------|-------------|-------------|
| | (mm)/(inch) | (mm)/(inch) | (mm)/(inch) | (mm)/(inch) | (mm)/(inch) |
| Value | 6.900/0.272 | 3.900/0.154 | 0.650/0.026 | 1.500/0.059 | 1.270/0.050 |





June 2015

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